

8-Channel, Triple 2-Channel Multiplexers

DESCRIPTION

The DG9451, and DG9453 are high precision single and dual supply CMOS analog multiplexers. DG9451 is an 8-channel multiplexer, and the DG9453 is a triple 2-channel multiplexer or triple SPDT.

Designed to operate from a +2.7 V to +12 V single supply or from a ± 2.5 V to ± 5 V dual supplies, the DG9451, and DG9453 are fully specified at +12 V, +5 V and ± 5 V. All control logic inputs have guaranteed 1.4 V high limit when operating from +5 V or ± 5 V supplies and 1.65 V when operating from a +12 V supply.

The DG9451, and DG9453 are precision multiplexers of low leakage, low charge injection, and low parasitic capacitance. They conduct equally well in both directions, offer rail to rail analog signal handling and can be used both as multiplexers as well as de-multiplexers.

The DG9451, and DG9453 operating temperature is specified from -40°C to $+85^{\circ}\text{C}$ and are available in 16 pin TSSOP and the ultra compact 1.8 mm x 2.6 mm miniQFN16 packages.

FEATURES

- +2.7 V to +12 V single supply operation
- ± 2.5 V to ± 5 V dual supply operation
- Fully specified at +12 V, +5 V, ± 5 V
- Low charge injection (< 0.5 pC typ.)
- High bandwidth: 270 MHz
- Low switch capacitance ($C_{s(off)}$ 1 pF typ.)
- Good isolation and crosstalk performance (typ. -44 dB at 100 MHz)
- MiniQFN16 package (1.8 mm x 2.6 mm)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

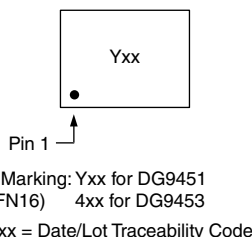
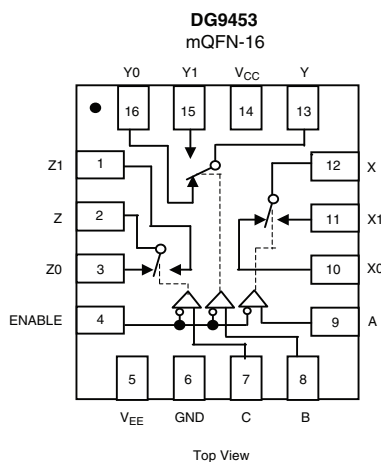
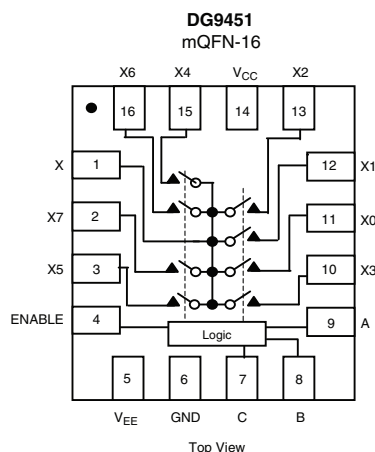


RoHS
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APPLICATIONS

- Data acquisition
- Medical and healthcare devices
- Control and automation equipments
- Test instruments
- Touch panels
- Consumer

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION





TRUTH TABLE					
ENABLE INPUT	SELECT INPUTS			ON SWITCHES	
	C	B	A	DG9451	DG9453
H	X	X	X	All Switches Open	All Switches Open
L	L	L	L	X to X0	X to X0, Y to Y0, Z to Z0
L	L	L	H	X to X1	X to X1, Y to Y0, Z to Z0
L	L	H	L	X to X2	X to X0, Y to Y1, Z to Z0
L	L	H	H	X to X3	X to X1, Y to Y1, Z to Z0
L	H	L	L	X to X4	X to X0, Y to Y0, Z to Z1
L	H	L	H	X to X5	X to X1, Y to Y0, Z to Z1
L	H	H	L	X to X6	X to X0, Y to Y1, Z to Z1
L	H	H	H	X to X7	X to X1, Y to Y1, Z to Z1

ORDERING INFORMATION		
TEMP. RANGE	PACKAGE	PART NUMBER
DG9451, DG9453		
-40 °C to +125 °C ^a	16-Pin miniQFN	DG9451EN-T1-E4
		DG9453EN-T1-E4

Note

a. -40 °C to +85 °C datasheet limits apply.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ °C}$, unless otherwise noted)			
PARAMETER		LIMIT	UNIT
V ₊ to V ₋		14	V
GND to V ₋		7	
Digital Inputs ^a , V _S , V _D		(V ₋) -0.3 to (V ₊) +0.3 or 30 mA, whichever occurs first	
Continuous Current (Any Terminal)		30	mA
Peak Current, S or D (Pulsed 1 ms, 10 % duty cycle)		100	
Storage Temperature		-65 to +150	°C
Power Dissipation ^b	16-Pin miniQFN ^{c, d}	525	mW
Thermal Resistance ^b	16-Pin miniQFN ^d	152	°C/W
Latch-up (per JESD78)		> 300	mA

Notes

- Signals on SX, DX, or INX exceeding V₊ or V₋ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- All leads welded or soldered to PC board.
- Derate 6.6 mW/°C above 70 °C.
- Manual soldering with iron is not recommended for leadless components. The miniQFN-16 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper lip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.



SPECIFICATIONS FOR DUAL SUPPLIES

PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPECIFIED V _{CC} = +5 V, V _{EE} = -5 V V _{IN} (A, B, C AND ENABLE) = 1.4 V, 0.3 V ^a		TEMP. ^b	TYP. ^c	-40 °C to +125 °C		-40 °C to +85 °C		UNIT	
						MIN. ^d	MAX. ^d	MIN. ^d	MAX. ^d		
Analog Switch											
Analog Signal Range ^e	V _{ANALOG}			Full	-	-5	5	-5	5	V	
On-Resistance	R _{ON}	I _S = 1 mA, V _D = -3 V, 0 V, +3 V		Room	66	-	100	-	100	Ω	
				Full	-	-	125	-	118		
On-Resistance Match	ΔR _{ON}	I _S = 1 mA, V _D = ± 3 V		Room	3	-	6	-	6		
				Full	-	-	10	-	8		
On-Resistance Flatness	R _{FLATNESS}	I _S = 1 mA, V _D = -3 V, 0 V, +3 V		Room	10.2	-	16	-	16	Ω	
				Full	-	-	20	-	18		
Switch Off Leakage Current	I _{S(off)}	V ₊ = 5.5 V, V ₋ = -5.5 V, V _D = ± 4.5 V, V _S = ∓ 4.5 V		Room	± 0.02	-1	1	-1	1	nA	
	Full			-	-50	50	-5	5			
	I _{D(off)}			Room	± 0.02	-1	1	-1	1		
				Full	-	-50	50	-5	5		
Channel On Leakage Current	I _{D(on)}	V ₊ = 5.5 V, V ₋ = -5.5 V, V _S = V _D = ± 4.5 V		Room	± 0.02	-1	1	-1	1	Ω	
				Full	-	-50	50	-5	5		
Digital Control											
V _{IN} (A, B, C and ENABLE) Low	V _{IL}			Full	-	-	0.3	-	0.3	V	
V _{IN} (A, B, C and ENABLE) High	V _{IH}			Full	-	1.4	-	1.4	-	V	
Input Current, V _{IN} Low	I _{IL}	V _{IN} (A, B, C and ENABLE) under test = 0.3 V		Full	0.01	-1	1	-1	1	μA	
Input Current, V _{IN} High	I _{IH}	V _{IN} (A, B, C and ENABLE) under test = 1.4 V		Full	0.01	-1	1	-1	1	μA	
Input Capacitance ^e	C _{IN}	f = 1 MHz		Room	3.4	-	-	-	-	pF	
Dynamic Characteristics											
Transition Time	t _{TRANS}	R _L = 300 Ω, C _L = 35 pF see figure 1, 2, 3		Room	66	-	180	-	180	ns	
				Full	-	-	218	-	207		
Enable Turn-On Time	t _{ON}			Room	152	-	250	-	250		
				Full	-	-	295	-	282		
Enable Turn-Off Time	t _{OFF}			Room	60	-	125	-	125		
				Full	-	-	136	-	131		
Break-Before-Make Time Delay	t _D			Room	32	-	-	-	-		
				Full	-	-	13	-	13		
Off Isolation ^e	OIRR	R _L = 50 Ω, C _L = 15 pF	f = 100 kHz	Room	< -90	-	-	-	-	dB	
			f = 10 MHz	Room	-65	-	-	-	-		
			f = 100 MHz	Room	-44	-	-	-	-		
Channel-to-Channel Crosstalk ^e	X _{TALK}		f = 100 kHz	Room	< -90	-	-	-	-		
			f = 10 MHz	Room	-74	-	-	-	-		
			f = 100 MHz	Room	-44	-	-	-	-		
Bandwidth, 3 dB	BW		R _L = 50 Ω	DG9451	Room	270	-	-	-	-	MHz
			DG9453	Room	525	-	-	-	-		
Charge Injection ^e	Q		V _g = 0 V, R _g = 0 Ω, C _L = 1 nF		Room	0.20	-	-	-	-	pC
Source Off Capacitance ^e	C _{S(off)}	f = 1 MHz	DG9451	Room	1	-	-	-	-	pF	
			DG9453	Room	1	-	-	-	-		
Drain Off Capacitance ^e	C _{D(off)}	f = 1 MHz	DG9451	Room	10	-	-	-	-		
			DG9453	Room	3	-	-	-	-		
Channel On Capacitance ^e	C _{D(on)}	f = 1 MHz	DG9451	Room	16	-	-	-	-		
			DG9453	Room	8	-	-	-	-		
Total Harmonic Distortion ^e	THD	Signal = 1 V _{RMS} , 20 Hz to 20 kHz, R _L = 600 Ω		Room	0.01	-	-	-	-	%	
Power Supplies											
Power Supply Current	I ₊	V _{CC} = +5 V, V _{EE} = -5 V V _{IN} (A, B, C and ENABLE) = 0 V or 5 V		Room	0.05	-	1	-	1	μA	
				Full	-	-	10	-	10		
Negative Supply Current	I ₋			Room	-0.05	-1	-	-1	-		
				Full	-	-10	-	-10	-		
Ground Current	I _{GND}			Room	-0.05	-1	-	-1	-		
				Full	-	-10	-	-10	-		



SPECIFICATIONS FOR UNIPOLAR SUPPLIES										
PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPECIFIED V _{CC} = +5 V, V _{EE} = 0 V V _{IN(A, B, C AND ENABLE)} = 1.4 V, 0.3 V ^a	TEMP. ^b	TYP. ^a	-40 °C to +125 °C		-40 °C to +85 °C		UNIT	
					MIN. ^d	MAX. ^d	MIN. ^d	MAX. ^d		
Analog Switch										
Analog Signal Range ^e	V _{ANALOG}		Full	-	0	5	0	5	V	
On-Resistance	R _{ON}	I _S = 1 mA, V _D = 0 V, +3.5 V	Room	105	-	165	-	165	Ω	
			Full	-	-	205	-	194		
On-Resistance Match	ΔR _{ON}	I _S = 1 mA, V _D = +3.5 V	Room	3.2	-	8	-	8		
			Full	-	-	13	-	10		
On-Resistance Flatness	R _{FLATNESS}	I _S = 1 mA, V _D = 0 V, +3 V	Room	17	-	26	-	26		
			Full	-	-	30	-	28		
Switch Off Leakage Current	I _{S(off)}	V ₊ = +5.5 V, V ₋ = 0 V V _D = 1 V/4.5 V, V _S = 4.5 V/1 V	Room	± 0.02	-1	1	-1	1	nA	
			Full	-	-50	50	-5	5		
	I _{D(off)}		Room	± 0.02	-1	1	-1	1		
			Full	-	-50	50	-5	5		
Channel On Leakage Current	I _{D(on)}	V ₊ = +5.5 V, V ₋ = 0 V V _D = V _S = 1 V/4.5 V	Room	± 0.02	-1	1	-1	1		
			Full	-	-50	50	-5	5		
Digital Control										
V _{IN(A, B, C and ENABLE)} Low	V _{IL}		Full	-	-	0.3	-	0.3	V	
V _{IN(A, B, C and ENABLE)} High	V _{IH}		Full	-	1.4	-	1.4			
Input Current, V _{IN} Low	I _L	V _{IN(A, B, C and ENABLE)} under test = 0.3 V	Full	0.01	-1	1	-1	1	μA	
Input Current, V _{IN} High	I _H	V _{IN(A, B, C and ENABLE)} under test = 1.4 V	Full	0.01	-1	1	-1	1		
Dynamic Characteristics										
Transition Time	t _{TRANS}	R _L = 300 Ω, C _L = 35 pF See Figure 1, 2, 3	Room	79	-	205	-	205	ns	
Enable Turn-On Time	t _{ON}		Full	-	-	295	-	285		
			Room	220	-	335	-	335		
Enable Turn-Off Time	t _{OFF}		Full	-	-	403	-	393		
			Room	93	-	150	-	150		
Break-Before-Make Time Delay	t _D		Full	-	-	173	-	163		
		Room	36	-	-	-	-			
Charge Injection ^e	Q	V _g = 0 V, R _g = 0 Ω, C _L = 1 nF	Full	0.81	-	-	-	-	pC	
			Room	< -90	-	-	-	-		
Off Isolation ^e	OIRR	R _L = 50 Ω, C _L = 15 pF f = 100 kHz	Room	< -90	-	-	-	-	dB	
Channel-to-Channel Crosstalk ^e	X _{TALK}		Room	< -90	-	-	-	-		
Dynamic Characteristics										
Source Off Capacitance ^e	C _{S(off)}	f = 1 MHz	DG9451	Room	1	-	-	-	pF	
			DG9453	Room	1	-	-	-		
Drain Off Capacitance ^e	C _{D(off)}	f = 1 MHz	DG9451	Room	11	-	-	-		
			DG9453	Room	3	-	-	-		
Channel On Capacitance ^e	C _{D(on)}	f = 1 MHz	DG9451	Room	17	-	-	-		
			DG9453	Room	9	-	-	-		
Power Supplies										
Power Supply Current	I ₊	V _{IN(A, B, C and ENABLE)} = 0 V or 5 V	Room	0.05	-	1	-	1	μA	
			Full	-	-	10	-	10		
Negative Supply Current	I ₋		Room	-0.05	-1	-	-1	-		
			Full	-	-10	-	-10	-		
Ground Current	I _{GND}		Room	-0.05	-1	-	-1	-		
			Full	-	-10	-	-10	-		

**SPECIFICATIONS FOR UNIPOLAR SUPPLIES**

PARAMETER	SYMBOL	TEST CONDITIONS UNLESS OTHERWISE SPECIFIED $V_{CC} = +12\text{ V}$, $V_{EE} = 0\text{ V}$ $V = 1.6\text{ V}$, 0.5 V^a		TEMP. ^b	TYP. ^c	-40 °C to +125 °C		-40 °C to +85 °C		UNIT
						MAX. ^d	MIN. ^d	MIN. ^d	MAX. ^d	
Analog Switch										
Analog Signal Range ^e	V_{ANALOG}			Full	-	0	12	0	12	V
On-Resistance	R_{ON}	$I_S = 1\text{ mA}$, $V_D = 0.7\text{ V}$, 6 V, 11.3 V		Room	68	-	105	-	105	Ω
				Full	-	-	143	-	137	
On-Resistance Match	ΔR_{ON}	$I_S = 1\text{ mA}$, $V_D = +0.7\text{ V}$		Room	4	-	7	-	7	
				Full	-	-	10	-	8	
On-Resistance Flatness	$R_{FLATNESS}$	$I_S = 1\text{ mA}$, $V_D = 0.7\text{ V}$, +11.3 V		Room	32	-	45	-	45	nA
				Full	-	-	49	-	47	
Switch Off Leakage Current	$I_{S(off)}$	$V_+ = +12\text{ V}$, $V_- = 0\text{ V}$ $V_D = 1\text{ V}/11\text{ V}$, $V_S = 11\text{ V}/1\text{ V}$		Room	± 0.02	-1	1	-1	1	
				Full	-	-50	50	-5	5	
	$I_{D(off)}$			Room	± 0.02	-1	1	-1	1	
				Full	-	-50	50	-5	5	
Channel On Leakage Current	$I_{D(on)}$	$V_+ = +12\text{ V}$, $V_- = 0\text{ V}$ $V_D = V_S = 1\text{ V}/11\text{ V}$		Room	± 0.02	-1	1	-1	1	nA
				Full	-	-50	50	-5	5	
Digital Control										
$V_{IN(A, B, C \text{ and } ENABLE)}$ Low	V_{IL}			Full	-	-	0.5	-	0.5	V
$V_{IN(A, B, C \text{ and } ENABLE)}$ High	V_{IH}			Full	-	1.6	-	1.6	-	
Input Current, V_{IN} Low	I_L	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 0.5 V		Full	0.01	-1	1	-1	1	μA
Input Current, V_{IN} High	I_H	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 1.6 V		Full	0.01	-1	1	-1	1	
Dynamic Characteristics										
Transition Time	t_{TRANS}	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ see figure 1, 2, 3		Room	55	-	135	-	135	ns
				Full	-	-	166	-	155	
Enable Turn-On Time	t_{ON}			Room	106	-	185	-	185	
				Full	-	-	219	-	205	
Enable Turn-Off Time	t_{OFF}			Room	65	-	130	-	130	
				Full	-	-	144	-	137	
Break-Before-Make Time Delay	t_D			Room	30	-	-	-	-	
				Full	-	-	12	-	12	
Charge Injection ^e	Q	$V_g = 0\text{ V}$, $R_g = 0\ \Omega$, $C_L = 1\text{ nF}$		Room	0.79	-	-	-	-	pC
Dynamic Characteristics										
Off Isolation ^e	OIRR	$R_L = 50\ \Omega$, $C_L = 15\text{ pF}$ $f = 100\text{ kHz}$		Room	< -90	-	-	-	-	dB
Channel-to-Channel Crosstalk ^e	X_{TALK}			Room	< -90	-	-	-	-	
Source Off Capacitance ^e	$C_{S(off)}$	$f = 1\text{ MHz}$	DG9451	Room	1	-	-	-	-	pF
			DG9453	Room	1	-	-	-	-	
Drain Off Capacitance ^e	$C_{D(off)}$	$f = 1\text{ MHz}$	DG9451	Room	9	-	-	-	-	
			DG9453	Room	3	-	-	-	-	
Channel On Capacitance ^e	$C_{D(on)}$	$f = 1\text{ MHz}$	DG9451	Room	15	-	-	-	-	
			DG9453	Room	8	-	-	-	-	
Power Supplies										
Power Supply Current	I_+	$V_{IN(A, B, C \text{ and } ENABLE)} = 0\text{ V}$ or 12 V		Room	0.05	-	1	-	1	μA
				Full	-	-	10	-	10	
Negative Supply Current	I_-			Room	-0.05	-1	-	-1	-	
				Full	-	-10	-	-10	-	
Ground Current	I_{GND}			Room	-0.05	-1	-	-1	-	
				Full	-	-10	-	-10	-	

Notesa. V_{IN} = input voltage to perform proper function.

b. Room -25 °C, Full = as determined by the operating temperature suffix.

c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.

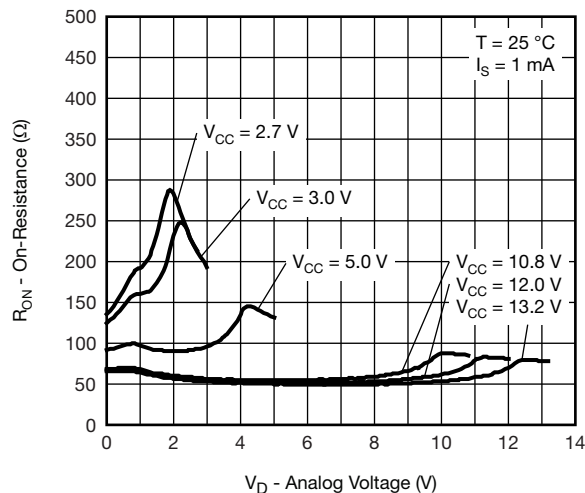
d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.

e. Guaranteed by design, not subject to production test.

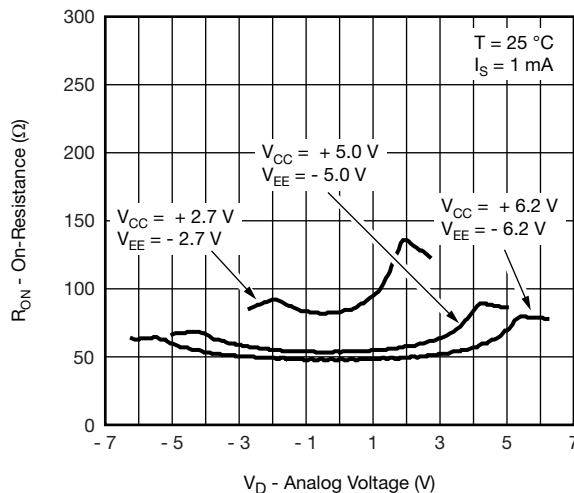
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



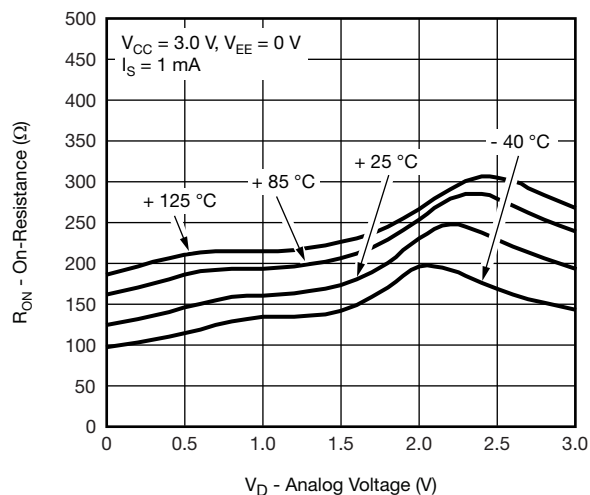
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



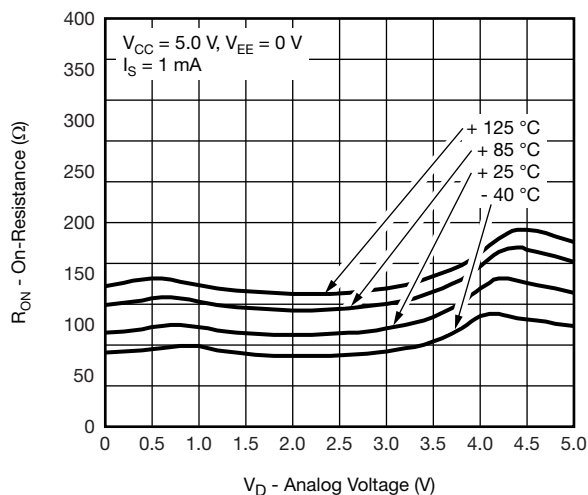
On-Resistance vs. V_D and Signal Supply Voltage



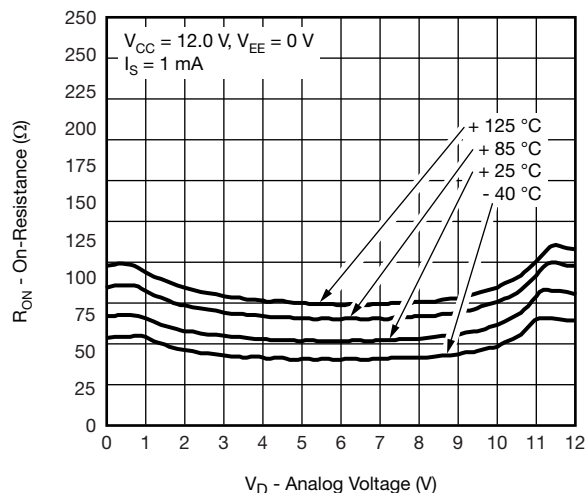
On-Resistance vs. Analog Voltage and Temperature



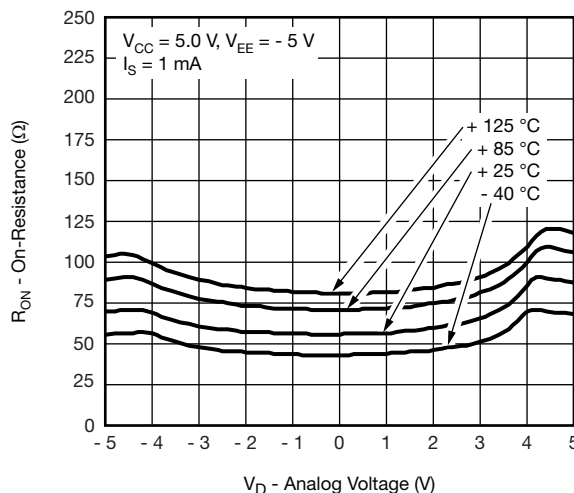
On-Resistance vs. Analog Voltage and Temperature



On-Resistance vs. Analog Voltage and Temperature



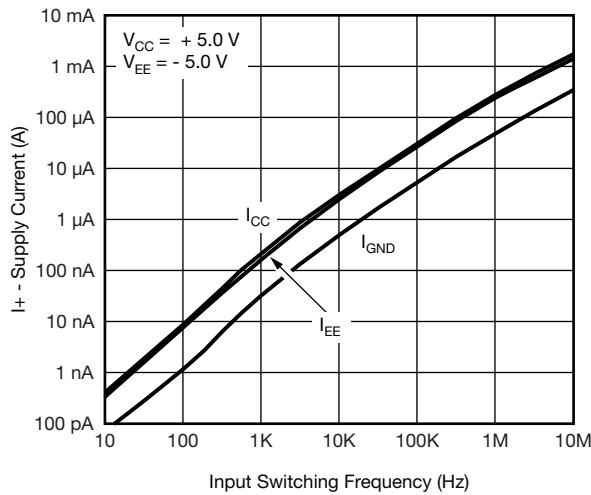
On-Resistance vs. Analog Voltage and Temperature



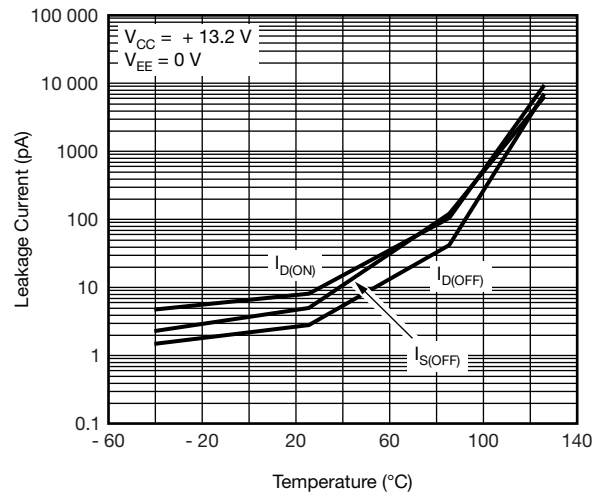
On-Resistance vs. Analog Voltage and Temperature



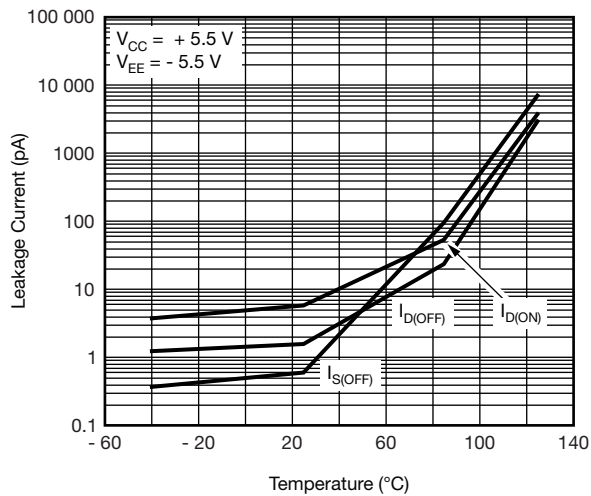
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



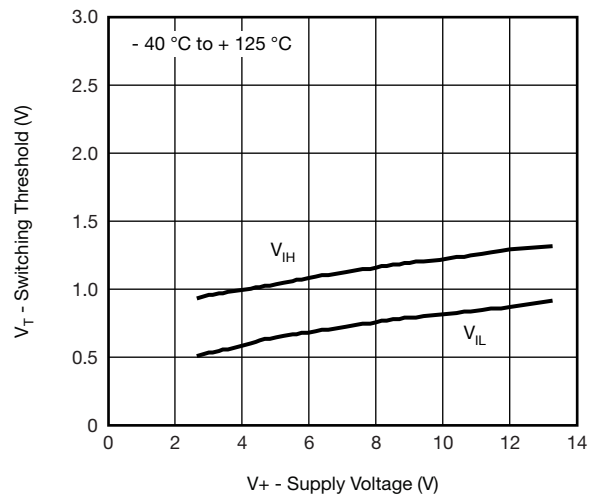
Supply Current vs. Input Switching Frequency



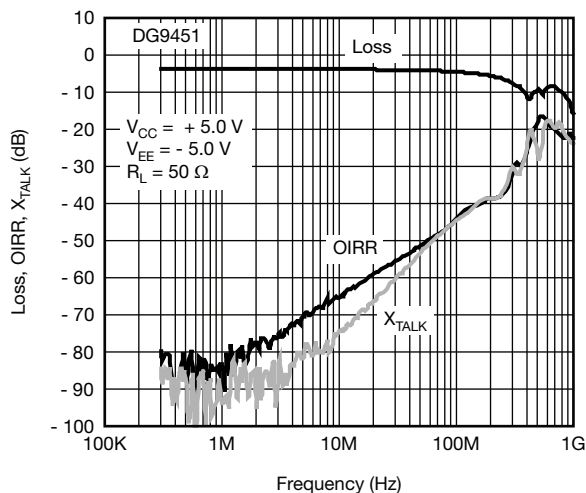
Leakage Current vs. Temperature



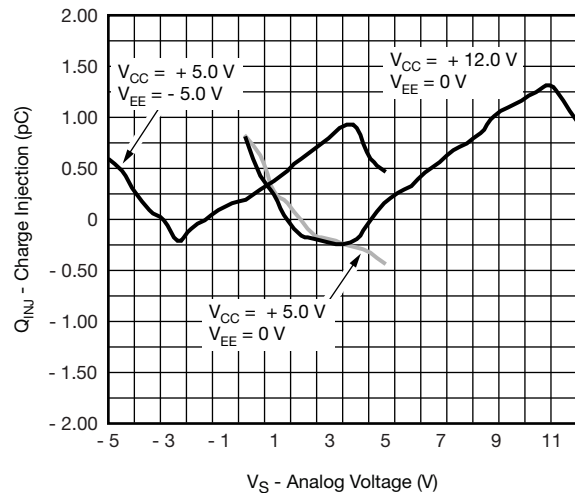
Leakage Current vs. Temperature



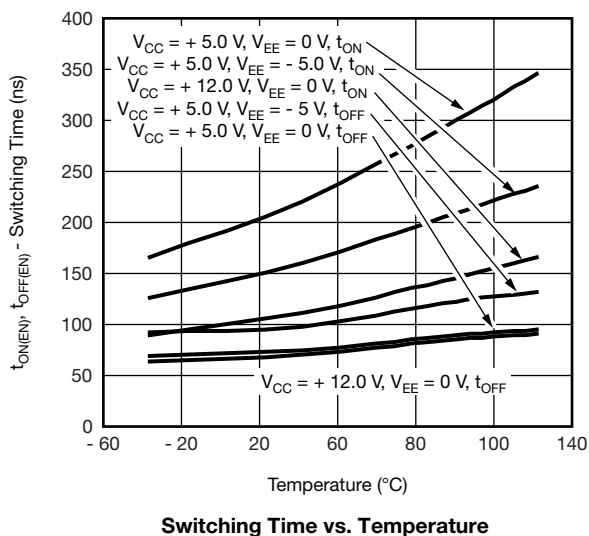
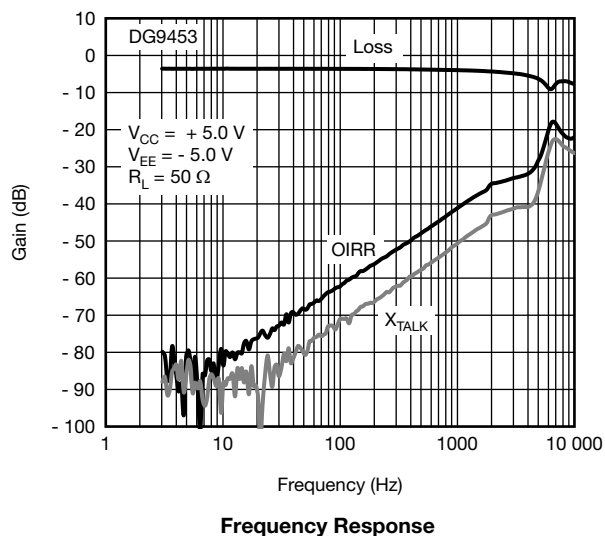
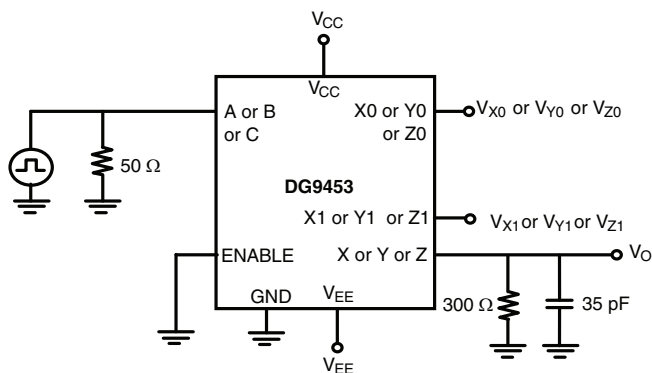
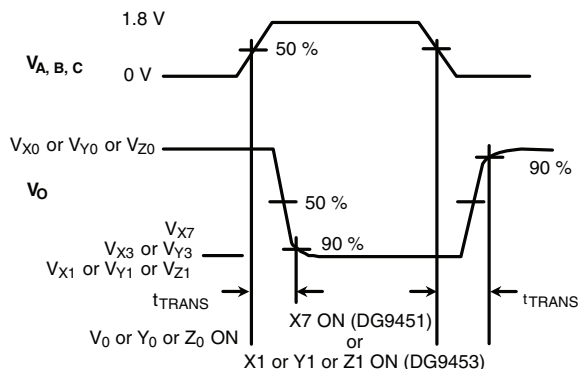
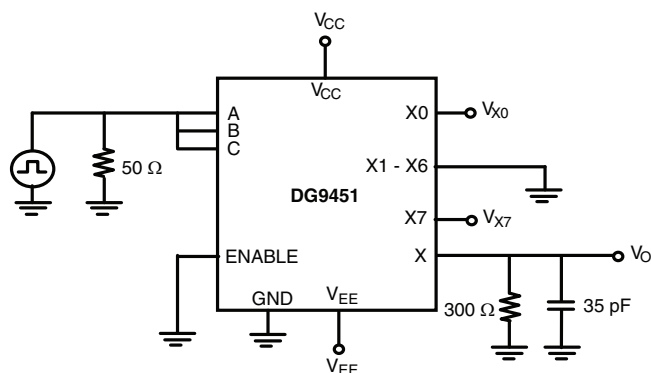
Switching Threshold vs. Supply Voltage

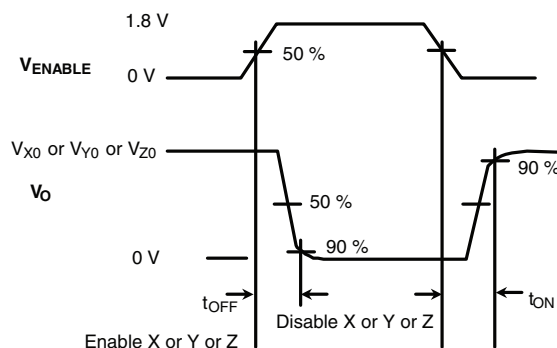
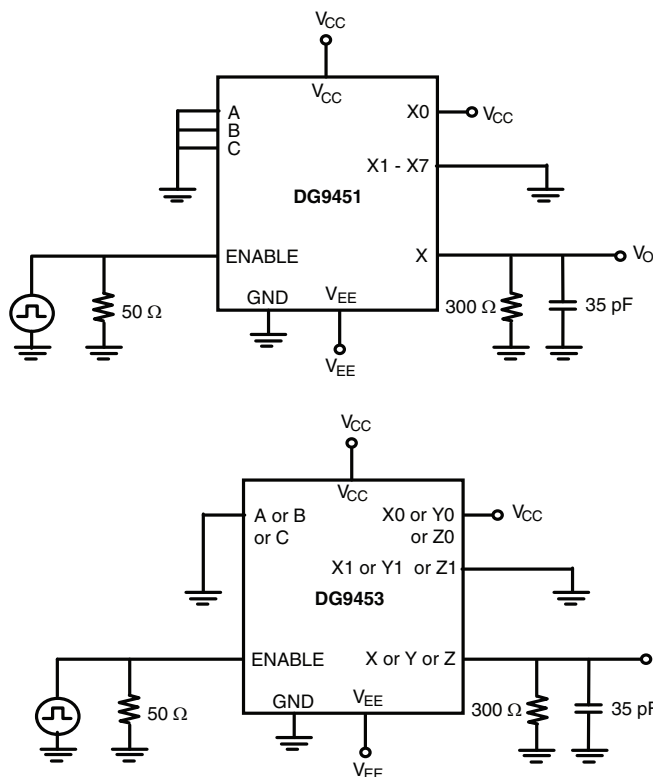
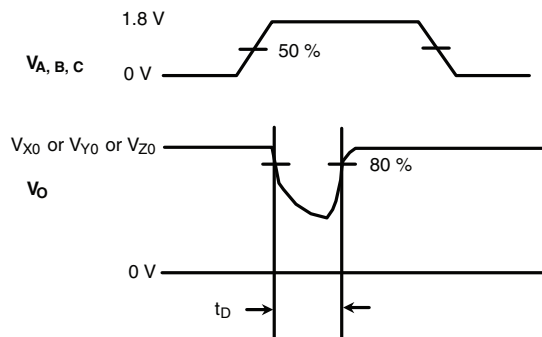
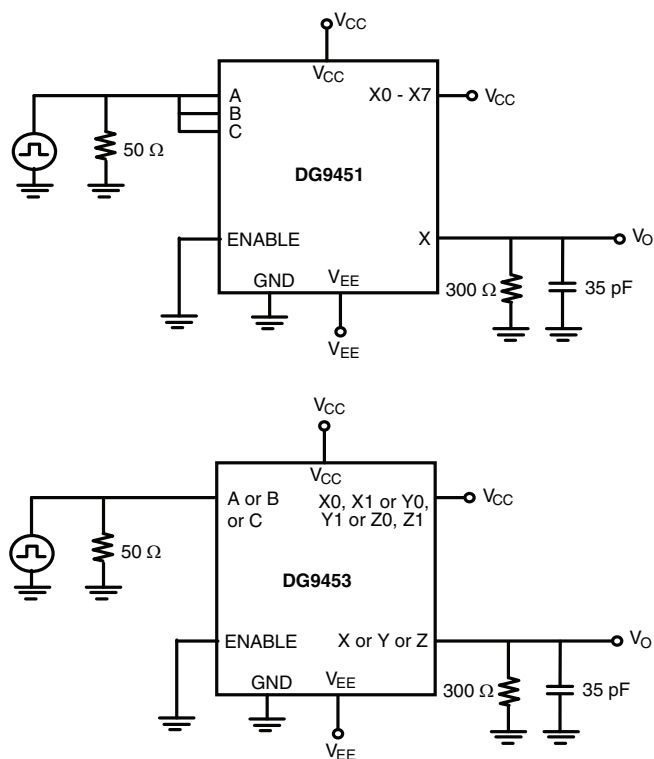


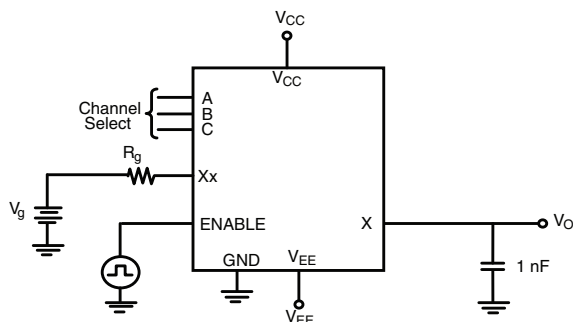
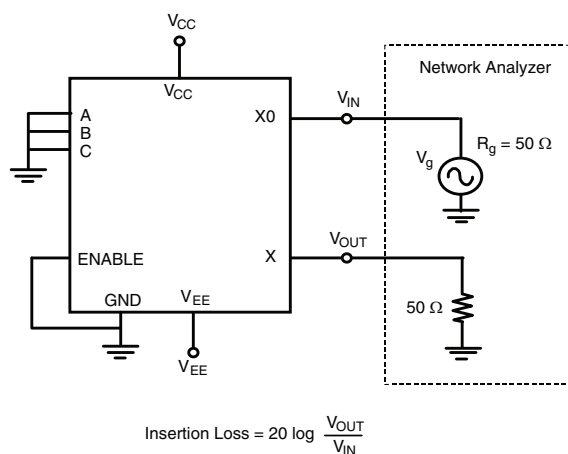
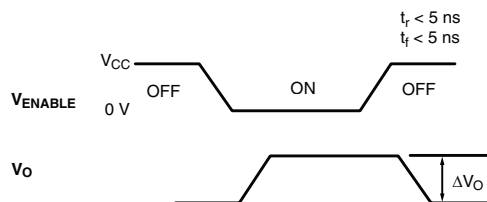
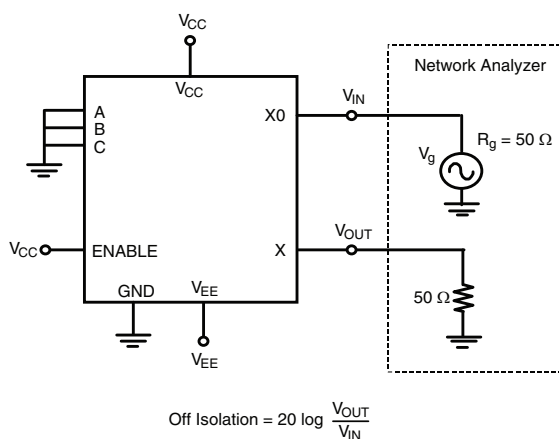
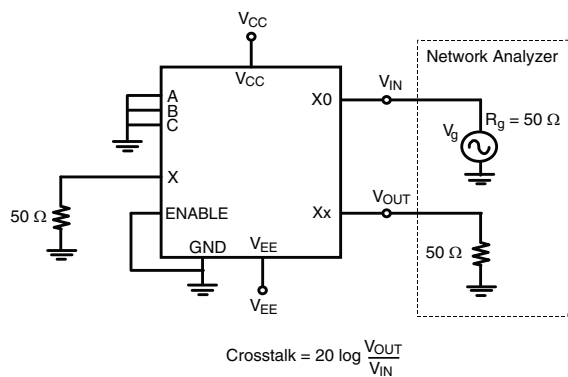
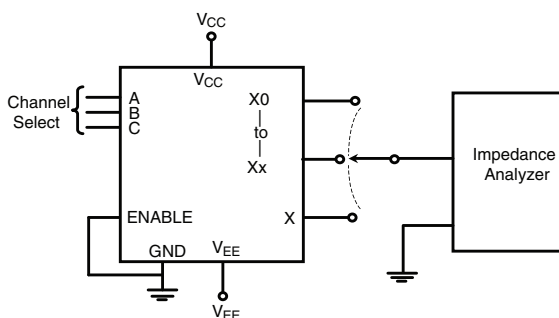
DG9451 Insertion Loss, Off-Isolation, Crosstalk vs. Frequency



DG9451 Charge Injection vs. Analog Voltage

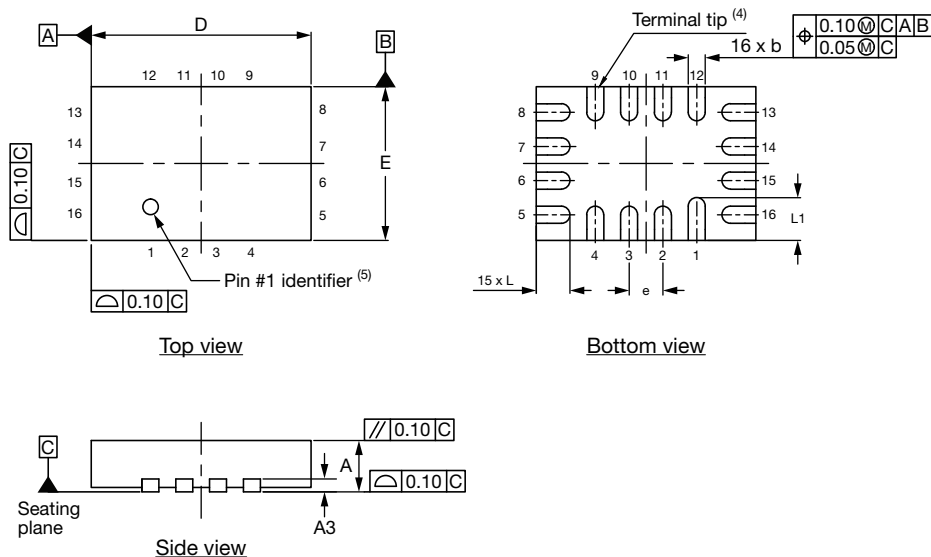
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

TEST CIRCUITS

Fig. 1 - Transition Time

TEST CIRCUITS

Fig. 2 - Enable Switching Time

Fig. 3 - Break-Before-Make

TEST CIRCUITS

Fig. 4 - Charge Injection

Fig. 5 - Insertion Loss

Fig. 7 - Off Isolation

Fig. 6 - Crosstalk

Fig. 8 - Source, Drain Capacitance

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?65020.

Thin miniQFN16 Case Outline



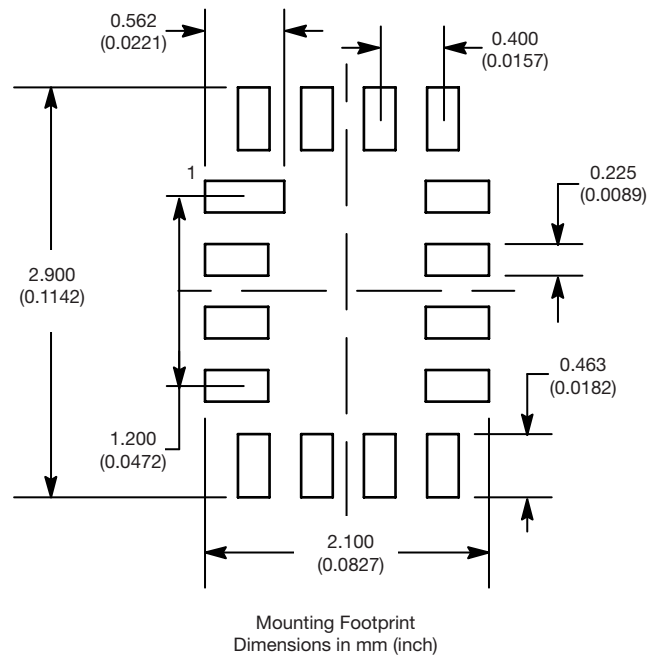
DIMENSIONS	MILLIMETERS ⁽¹⁾			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.50	0.55	0.60	0.020	0.022	0.024
A1	0	-	0.05	0	-	0.002
A3	0.15 ref.			0.006 ref.		
b	0.15	0.20	0.25	0.006	0.008	0.010
D	2.50	2.60	2.70	0.098	0.102	0.106
e	0.40 BSC			0.016 BSC		
E	1.70	1.80	1.90	0.067	0.071	0.075
L	0.35	0.40	0.45	0.014	0.016	0.018
L1	0.45	0.50	0.55	0.018	0.020	0.022
N ⁽³⁾	16			16		
Nd ⁽³⁾	4			4		
Ne ⁽³⁾	4			4		

Notes

- (1) Use millimeters as the primary measurement.
- (2) Dimensioning and tolerances conform to ASME Y14.5M. - 1994.
- (3) N is the number of terminals. Nd and Ne is the number of terminals in each D and E site respectively.
- (4) Dimensions b applies to plated terminal and is measured between 0.15 mm and 0.30 mm from terminal tip.
- (5) The pin 1 identifier must be existed on the top surface of the package by using identification mark or other feature of package body.
- (6) Package warpage max. 0.05 mm.

ECN: T16-0226-Rev. B, 09-May-16
DWG: 6023

RECOMMENDED MINIMUM PADS FOR MINI QFN 16L





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